

# ZXTC2062E6 20V, SOT23-6, complementary medium power transistors

## Summary

 $BV_{CEO} > 20 (-20)V$ 

 $BV_{ECO} > 5 (-4)V$ 

 $I_{C(cont)} = 4 (-3.5)A$ 

 $V_{CE(sat)} < 50 (-65) mV @ 1A$ 

 $R_{CE(sat)} = 35 (54) m\Omega$ 

 $P_{D} = 1.1W$ 



Advanced process capability has been used to achieve this high performance device. Combining NPN and PNP transistors in the SOT23-6 package provides a compact solution for the intended applications

## **Features**

- NPN-PNP combination
- Very low saturation voltage
- · High gain
- SOT23-6 package

### **Applications**

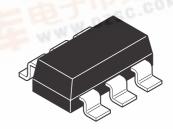
- MOSFET and IGBT gate driving
- Motor drive

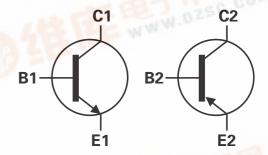
## **Ordering information**

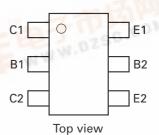
DEVICE	Reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXTC2062E6TA	7	8	3000

## **Device marking**

2062







## Absolute maximum and thermal ratings

PARAMETER	Symbol	Limit	Unit
Collector-base voltage	V <sub>CBO</sub>	100(-25)	V
Collector-emitter voltage	V <sub>CEO</sub>	(-)20	V
Emitter-collector voltage (reverse blocking)	V <sub>ECO</sub>	5(-4)	V
Emitter-base voltage	V <sub>EBO</sub>	(-)7	V
Continuous collector current <sup>(c)(f)</sup>	I <sub>C</sub>	4(-3.5)	Α
Peak pulse current	I <sub>CM</sub>	(-)10	Α
Base current	I <sub>B</sub>	(-)1	Α
Power dissipation at T <sub>A</sub> =25°C <sup>(a)(f)</sup>	P <sub>D</sub>	0.7	W
Linear derating factor		5.6	mW/°C
Power dissipation at T <sub>A</sub> =25°C <sup>(b)(f)</sup>	P <sub>D</sub>	0.9	W
Linear derating factor		7.2	mW/°C
Power dissipation at T <sub>A</sub> =25°C <sup>(b)(g)</sup>	P <sub>D</sub>	1.1	W
Linear derating factor		8.8	mW/°C
Power dissipation at T <sub>A</sub> =25°C <sup>(c)(f)</sup>	P <sub>D</sub>	1.1	W
Linear derating factor		8.8	mW/°C
Power dissipation at T <sub>A</sub> =25°C <sup>(d)(f)</sup>	P <sub>D</sub>	1.7	W
Linear derating factor		13.6	mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to +150	°C
Thermal resistance junction to ambient <sup>(a)(f)</sup>	$R_{\theta JA}$	179	°C/W
Thermal resistance junction to ambient <sup>(b)(f)</sup>	$R_{\theta JA}$	139	°C/W
Thermal resistance junction to ambient <sup>(b)(g)</sup>	$R_{\theta JA}$	113	°C/W
Thermal resistance junction to ambient <sup>(c)(f)</sup>	$R_{\theta JA}$	113	°C/W
Thermal resistance junction to ambient <sup>(d)(f)</sup>	$R_{\theta JA}$	73	°C/W

### NOTES:

<sup>(</sup>a) For a device surface mounted on 15mm x 15mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

<sup>(</sup>b) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

<sup>(</sup>c) For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.

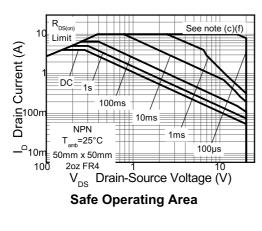
<sup>(</sup>d) As above measured at t<5 seconds.

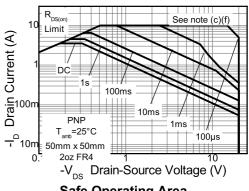
<sup>(</sup>e) Repetitive rating - pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.

<sup>(</sup>f) For device with one active die, both collectors attached to a common sink.

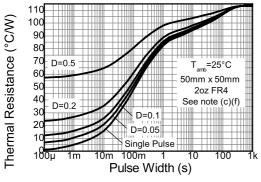
<sup>(</sup>g) For device with two active dice running at equal power, split sink 50% to each collector.

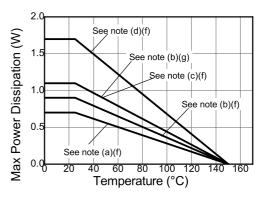
### Thermal characteristics





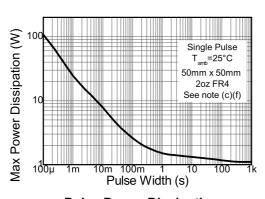
**Safe Operating Area** 





**Transient Thermal Impedance** 

**Derating Curve** 



**Pulse Power Dissipation** 

## **ELECTRICAL CHARACTERISTICS** (at Tamb = 25°C unless otherwise stated).

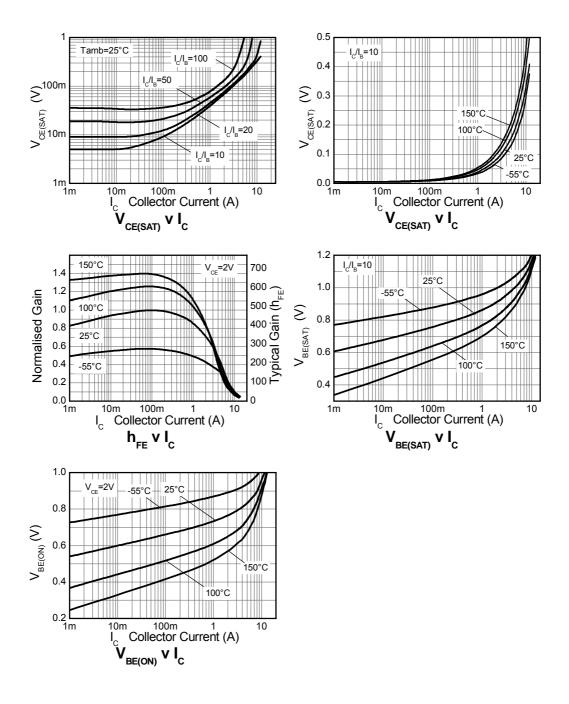
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
		100(-25)	140(-55)		V	$I_C = (-)100 \mu A$
Collector-emitter	BV <sub>CEO</sub>	(-)20	35(-45)		V	I <sub>C</sub> = (-)10mA <sup>(*)</sup>
breakdown voltage						
(base open)	D) (	( ) =	()0.0			()400 A
Emitter-base	BV <sub>EBO</sub>	(-)7	(-)8.3		V	I <sub>E</sub> = (-)100 A
breakdown voltage	D) /	F/ 4\	C/ O E)		17	
Emitter-collector	BV <sub>ECO</sub>	5(-4)	6(-8.5)		V	I <sub>E</sub> = (-)100 A
breakdown voltage (base open)						
Collector-base cut-off	la-a		<1	(-)50	nA	V <sub>CB</sub> =100(-25)V
current	ІСВО				A	$V_{CB} = 100(-25)V$ , $T_{amb} = 100^{\circ}C$
Emitter-base cut-off			<1	(-)0.5 (-)50	nA	$V_{EB} = (-)5.6V$
current	I <sub>EBO</sub>		< 1	(-/50	IIA	v <sub>EB</sub> = (-/3.0v
Collector-emitter	V <sub>CE(sat)</sub>		40(-55)	50(-65)	mV	$I_C = (-)1A, I_B = (-)100mA^{(*)}$
saturation voltage	CE(sat)		60(-100)	75(-135)	mV	$I_C = (-)1A$ , $I_B = (-)20mA^{(*)}$
						_ =
			95(-185)	115(-280)	mV	$I_C = (-)2A, I_B = (-)40mA^{(*)}$
			(-190)	(-250)	mV	$(I_C = -3.5A, I_B = -175mA)^{(*)}$
			140	190	mV	$I_C = 4A$ , $I_B = 200 \text{mA}^{(*)}$
Base-emitter	V <sub>BE(sat)</sub>		(-925)	(-1000)	mV	$(I_C = -3.5A, I_B = -175mA^{(*)})$
saturation voltage			940	1050	mV	$I_C = 4A$ , $I_B = 200 \text{mA}^{(*)}$
Base-emitter turn-on	V <sub>BE(on)</sub>		(-835)	(-900)	mV	$(I_C = -3.5A, V_{CE} = -2V^{(*)})$
voltage			810	900	mV	$I_C = 4A$ , $V_{CE} = 2V^{(*)}$
Static forward current	h <sub>FE</sub>	300(300)	450(450)	900(900)		I <sub>C</sub> = (-)10mA, V <sub>CE</sub> = (-)2V <sup>(*)</sup>
transfer ratio		280(170)	420(300)			$I_C = (-)1A, V_{CE} = (-)2V^{(*)}$
		(65)	(100)			$(I_C = -3.5A, V_{CF} = -2V^{(*)})$
		140	210			$I_{C} = 4A, V_{CF} = 2V^{(*)}$
			(15)			$(I_C = -10A, V_{CF} = -2V^{(*)})$
			15			$I_C = 15A, V_{CE} = 2V^{(*)}$
Transition frequency	f <sub>T</sub>		215		MHz	$I_C = (-)50 \text{mA}, V_{CE} = (-)10 \text{V}$
Transition frequency	''		(290)		IVIIIL	f = 100MHz
Output capacitance	C		17(21)	25(30)	pF	
	C <sub>OBO</sub>			23(30)		$V_{CB} = (-)10V, f = 1MHz^{(*)}$
Delay time	t <sub>d</sub>		68(56)		ns	$V_{CC} = (-)10V. I_C = (-)1A,$
Rise time	t <sub>r</sub>		72(68)		ns	$I_{B1} = -I_{B2} = (-)10$ mA.
Storage time	ts		361(158)		ns	. DI 'BZ \ / . 3
Fall time	t <sub>f</sub>		64(59)		ns	

### NOTES:

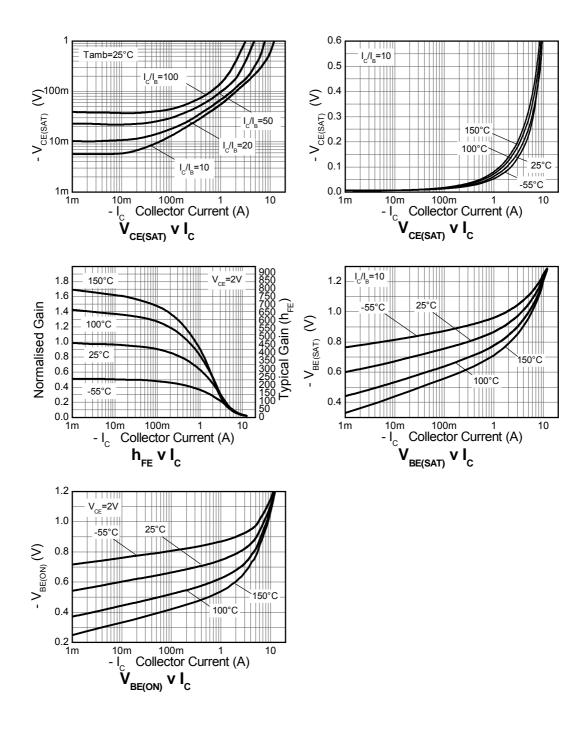
<sup>(\*)</sup> Measured under pulsed conditions. Pulse width  $\leq 300 \mu s;$  duty cycle  $\leq 2\%.$ 

<sup>() =</sup> PNP

## **NPN** electrical characteristics

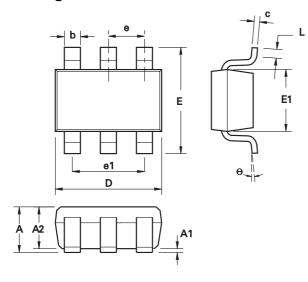


## **PNP** electrical characteristics

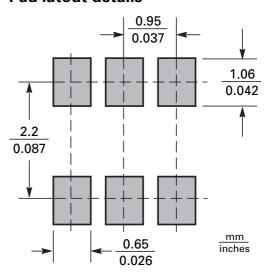


## Package outline SOT23-6

# Package outline



## Pad latout details



DIM	Millimeters		Inches		
	Min.	Max.	Min.	Max.	
Α	0.90	1.45	0.354	0.0570	
A1	0.00	0.15	0.00	0.0059	
A2	0.90	1.30	0.0354	0.0511	
b	0.35	0.50	0.0078	0.0196	
С	0.09	0.26	0.0035	0.0102	
D	2.70	3.10	0.1062	0.1220	
Е	2.20	3.20	0.0866	0.1181	
E1	1.30	1.80	0.0511	0.0708	
L	0.10	0.60	0.0039	0.0236	
е	0.95 REF		0.0374 REF		
e1	1.90 REF		0.0748 REF		
L	0°	30°	0°	30°	

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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